CEL

NEC's 3.2 V, 2 W, L&S BAND MEDIUM POWER SILICON LD-MOSFET

NE5520279A

FEATURES

- LOW COST PLASTIC SURFACE MOUNT PACKAGE: 5.7x5.7x1.1 mm MAX
- HIGH OUTPUT POWER:

+32 dBm TYP

HIGH LINEAR GAIN:

10 dB TYP @ 1.8 GHz

• HIGH POWER ADDED EFFICIENCY:

45% TYP at 1.8 GHz

· SINGLE SUPPLY:

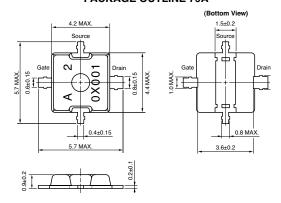
2.8 to 6.0 V

DESCRIPTION

NEC's NE5520279A is an N-Channel silicon power laterally diffused MOSFET specially designed as the power amplifier for mobile and fixed wireless applications. Die are manufactured using NEC's NEWMOS technology (NEC's 0.6 μm WSi gate lateral MOSFET) and housed in a surface mount package.

OUTLINE DIMENSIONS (Units in mm)

PACKAGE OUTLINE 79A



APPLICATIONS

- DIGITAL CELLULAR PHONES:
 3.2 V DCS1800 Handsets
- 0.7-2.5 GHz FIXED WIRELESS ACCESS
- W-LAN
- · SHORT RANGE WIRELESS
- · RETAIL BUSINESS RADIO
- SPECIAL MOBILE RADIO

ELECTRICAL CHARACTERISTICS (TA = 25°C)

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		NE5520279A				
PACKAGE OUTLINE			79A			
SYMBOLS	CHARACTERISTICS	UNITS	MIN	TYP	MAX	TEST CONDITIONS
Роит	Output Power	dBm	30.5	32.0		f = 1.8 GHz, Vps = 3.2 V,
GL	Linear Gain		IDSQ = 700 mA, PIN = 25 dBm, except			
ηADD	Power Added Efficiency	%	40	45		PIN = 5 dBm for Linear Gain
ΙD	Drain Current	mA		800		
lgss	Gate-to-Source Leakage Current	nA			100	Vgs = 5.0 V
IDSS	Saturated Drain Current (Zero Gate Voltage Drain Current)	nA			100	VDS = 6.0 V
V TH	Gate Threshold Voltage	V	1.0	1.4	1.9	VDS = 3.5 V, IDS = 1 mA
g m	Transconductance	S		1.3		VDS = 3.5 V, IDS = 700 mA
BVDSS	Drain-to-Source Breakdown Voltage	V	15	18		IDSS = 10 μA
RTH	Thermal Resistance	°C/W			8	Channel-to-Case
	SYMBOLS POUT GL ηADD ID IGSS IDSS VTH gm BVDSS	PART NUMBER PACKAGE OUTLINE SYMBOLS CHARACTERISTICS POUT Output Power GL Linear Gain ηADD Power Added Efficiency ID Drain Current IGSS Gate-to-Source Leakage Current IDSS Saturated Drain Current (Zero Gate Voltage Drain Current) VTH Gate Threshold Voltage gm Transconductance BVDSS Drain-to-Source Breakdown Voltage	PACKAGE OUTLINE SYMBOLS CHARACTERISTICS UNITS POUT Output Power dBm GL Linear Gain dB ηADD Power Added Efficiency % ID Drain Current mA IGSS Gate-to-Source Leakage Current nA IDSS Saturated Drain Current (Zero Gate Voltage Drain Current) nA VTH Gate Threshold Voltage V gm Transconductance S BVDSS Drain-to-Source Breakdown Voltage V	PART NUMBER PACKAGE OUTLINE SYMBOLS CHARACTERISTICS UNITS MIN POUT Output Power dBm 30.5 GL Linear Gain dB ηADD Power Added Efficiency % 40 ID Drain Current mA IGSS Gate-to-Source Leakage Current nA IDSS Saturated Drain Current (Zero Gate Voltage Drain Current) VTH Gate Threshold Voltage V 1.0 gm Transconductance S BVDSS Drain-to-Source Breakdown Voltage V 15	PART NUMBER PACKAGE OUTLINE NE5520279 SYMBOLS CHARACTERISTICS UNITS MIN TYP POUT Output Power dBm 30.5 32.0 GL Linear Gain dB 10 MADD Power Added Efficiency % 40 45 ID Drain Current mA 800 IGSS Gate-to-Source Leakage Current nA NA IDSS Saturated Drain Current (Zero Gate Voltage Drain Current) NA 1.0 1.4 VTH Gate Threshold Voltage V 1.0 1.4 gm Transconductance S 1.3 BVDss Drain-to-Source Breakdown Voltage V 15 18	PART NUMBER PACKAGE OUTLINE NE5520279A SYMBOLS CHARACTERISTICS UNITS MIN TYP MAX POUT Output Power dBm 30.5 32.0 GL Linear Gain dB 10 MADD Power Added Efficiency % 40 45 ID Drain Current mA 800 IGSS Gate-to-Source Leakage Current nA 100 IDSS Saturated Drain Current (Zero Gate Voltage Drain Current) nA 100 VTH Gate Threshold Voltage V 1.0 1.4 1.9 gm Transconductance S 1.3 1.3 BVDss Drain-to-Source Breakdown Voltage V 15 18

Notes:

- 1. DC performance is 100% testing. RF performance is testing several samples per wafer. Wafer rejection criteria for standard devices is 1 reject for several samples.
- 2. Pin = 5 dBm

ABSOLUTE MAXIMUM RATINGS¹ (TA = 25 °C)

SYMBOLS	PARAMETERS	UNITS	RATINGS
VDS	Drain Supply Voltage	V	15.0
Vgs	Gate Supply Voltage	V	5.0
lD	Drain Current	Α	0.6
lD	Drain Current (Pulse Test) ²	Α	1.2
Рт	Total Power Dissipation	W	12.5
Тсн	Channel Temperature	°C	125
Тѕтс	Storage Temperature	°C	-55 to +125

Note:

- 1. Operation in excess of any one of these parameters may result in permanent damage.
- 2. Duty Cycle 50%, Ton = 1 s.

ORDERING INFORMATION

PART NUMBER	QTY
NE5520279A-T1-A	

RECOMMENDED OPERATING LIMITS

SYMBOLS	PARAMETERS	UNITS	TYP	MAX
VDS	Drain to Source Voltage	V	3.0	6.0
Vgs	Gate Supply Voltage	V	2.0	3.0
IDS	Drain Current ¹	Α	0.8	1.0
Pin	Input Power f = 1.8 GHz, VDS = 3.2 V	dBm	25	30

Note:

LARGE SIGNAL IMPEDANCE

 $(V_{DS} = 3.2 \text{ V}, I_{D} = 700 \text{ mA}, f = 1.8 \text{ GHz})$

FREQUENCY (GHz)	Z in (Ω)	Z ol (Ω) ¹	
1.8	1.77 –j6.71	1.25 -j5.73	

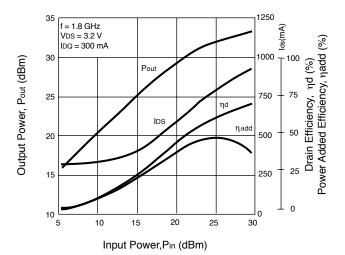
Note:

 ZoL is the conjugate of optimum load impedance at given voltage, idling current, input power.

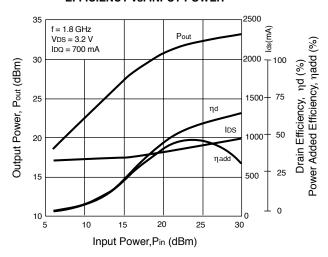
^{1.} Duty Cycle \leq 50%, Ton \leq 1 s.

TYPICAL PERFORMANCE CURVES (TA = 25°C)

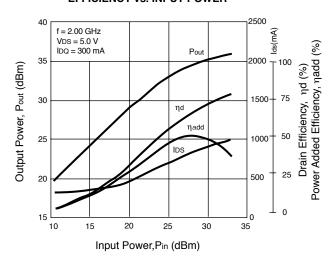
OUTPUT POWER, DRAIN CURRENT EFFICIENCY vs. INPUT POWER



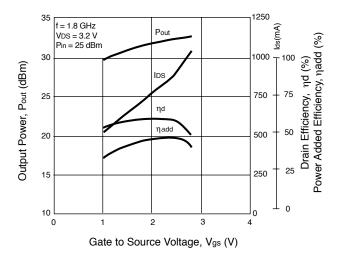
OUTPUT POWER, DRAIN CURRENT EFFICIENCY vs. INPUT POWER



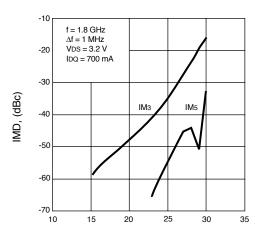
OUTPUT POWER, DRAIN CURRENT EFFICIENCY vs. INPUT POWER



OUTPUT POWER, DRAIN CURRENT EFFICIENCY vs. GATE TO SOURCE VOLTAGE

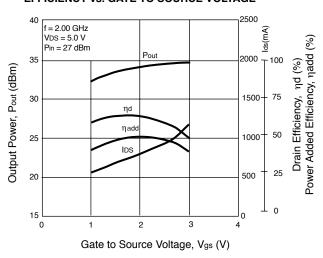


IMD vs. TWO TONE OUTPUT POWER



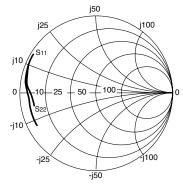
Average Two Tone Ouput Power, Pout (dBm)

OUTPUT POWER, DRAIN CURRENT EFFICIENCY vs. GATE TO SOURCE VOLTAGE

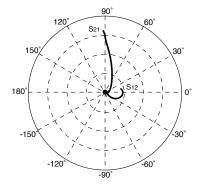


TYPICAL SCATTERING PARAMETERS (TA = 25°C)

Note: This file and many other s-parameter files can be downloaded from www.cel.com



Coordinates in Ohms Frequency in GHz VD = 5.0 V, ID = 400 mA



NE5520279A

VD = 5.0 V, ID = 400 mA

FREQUENCY		- 311	S	21	5	S12	9	S22	K	MAG ¹
GHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG		(dB)
0.100	0.885	-152.5	11.510	98.5	0.021	10.3	0.830	-170.1	0.03	27.43
0.200	0.885	-166.9	5.882	87.7	0.022	0.2	0.833	-175.4	0.07	24.21
0.300	0.883	-172.4	3.896	80.8	0.022	- 5.2	0.840	-177.5	0.11	22.51
0.400	0.885	-175.6	2.897	75.2	0.021	- 9.2	0.849	-178.5	0.14	21.31
0.500	0.887	-177.9	2.278	70.1	0.021	- 12.9	0.851	-179.3	0.20	20.41
0.600	0.890	-179.8	1.865	65.3	0.020	- 15.7	0.856	179.9	0.27	19.66
0.700	0.895	178.7	1.569	60.7	0.020	- 19.3	0.861	179.1	0.30	19.05
0.800	0.900	177.3	1.346	56.5	0.019	- 21.8	0.869	178.4	0.32	18.55
0.900	0.905	176.0	1.168	52.4	0.018	- 24.5	0.876	177.9	0.36	18.12
1.000	0.911	174.6	1.024	48.5	0.017	- 27.2	0.882	177.2	0.39	17.79
1.100	0.916	173.6	0.911	44.7	0.016	- 28.8	0.894	176.5	0.36	17.48
1.200	0.921	172.2	0.812	40.9	0.015	- 30.8	0.898	175.5	0.42	17.21
1.300	0.924	171.0	0.728	37.5	0.015	- 33.3	0.903	174.7	0.47	16.93
1.400	0.926	169.9	0.655	34.1	0.014	- 33.9	0.907	173.9	0.62	16.84
1.500	0.927	168.7	0.594	30.8	0.013	- 36.0	0.914	172.9	0.68	16.65
1.600	0.929	167.5	0.541	27.9	0.012	- 36.6	0.921	172.2	0.76	16.54
1.700	0.930	166.3	0.494	25.1	0.011	- 37.3	0.925	171.5	0.98	16.58
1.800	0.931	165.2	0.451	22.4	0.010	- 38.5	0.926	170.7	1.22	13.67
1.900	0.935	164.1	0.415	19.6	0.009	- 38.5	0.930	169.8	1.35	12.97
2.000	0.937	162.9	0.384	17.1	0.009	- 38.8	0.937	169.0	1.33	12.95
2.100	0.941	161.8	0.356	14.9	0.008	- 36.9	0.942	168.5	1.45	12.62
2.200	0.944	160.6	0.329	12.6	0.007	- 40.8	0.941	167.8	1.74	11.58
2.300	0.949	159.5	0.305	10.2	0.006	- 36.6	0.942	167.0	2.04	11.01
2.400	0.950	158.3	0.285	7.7	0.006	- 36.0	0.947	166.0	2.04	11.00
2.500	0.955	157.3	0.267	5.8	0.005	- 34.6	0.952	165.5	2.04	11.27
2.600	0.956	156.3	0.248	4.0	0.005	- 32.7	0.953	164.9	2.59	10.34
2.700	0.958	155.4	0.232	2.0	0.004	- 31.4	0.952	164.2	3.32	9.53
2.800	0.957	154.5	0.217	0.0	0.003	- 27.2	0.954	163.2	4.54	8.76
2.900	0.959	153.8	0.204	- 1.6	0.003	- 22.0	0.958	162.4	5.69	8.58
3.000	0.959	152.9	0.192	- 3.1	0.003	- 5.2	0.961	161.9	5.78	8.26
3.100	0.962	152.5	0.180	- 4.5	0.002	- 1.3	0.960	161.1	9.71	7.87
3.200	0.961	151.5	0.170	- 6.1	0.002	27.2	0.960	160.2	9.31	7.08
3.300	0.965	150.8	0.161	- 7.6	0.002	56.3	0.964	159.4	9.54	7.19
3.400	0.967	150.1	0.152	- 8.8	0.002	79.5	0.965	158.6	7.96	6.89
3.500	0.971	149.6	0.144	- 10.0	0.003	86.6	0.963	157.6	5.89	6.46

Note:

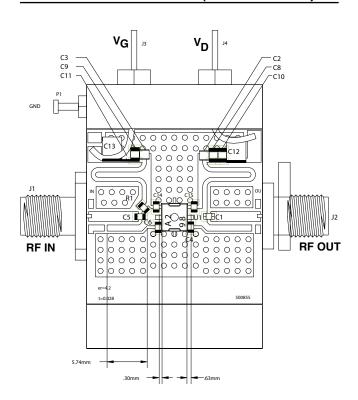
1. Gain Calculation:

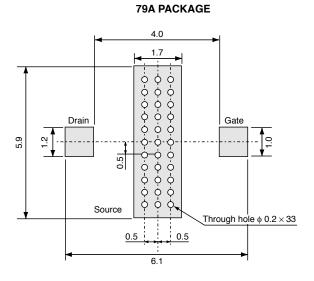
 $MAG = \frac{|S_21|}{|S_{12}|} \left(K \pm \sqrt{K^2 - 1} \right). \ When \ K \leq 1, \ MAG \ is \ undefined \ and \ MSG \ values \ are \ used. \ MSG = \frac{|S_21|}{|S_{12}|} \ , \ K = \frac{1 + |\Delta|^2 - |S_{11}|^2 - |S_{22}|^2}{2 \ |S_{12}| S_{21}|}, \ \Delta = S_{11} \ S_{22} - S_{21} \ S_{12} + S_{22} + S_{21} \ S_{22} + S_{22} + S_{21} \ S_{22} + S_{22} + S_{21} \ S_{22} + S_{22}$

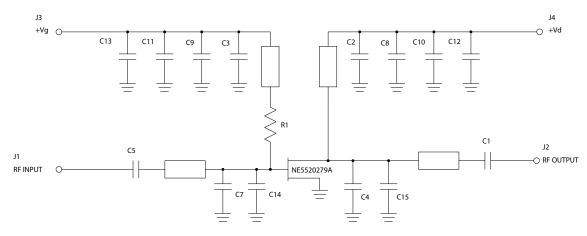
MAG = Maximum Available Gain MSG = Maximum Stable Gain

APPLICATION CIRCUIT (2.40-2.48 GHz)

P.C.B. LAYOUT (Units in mm)



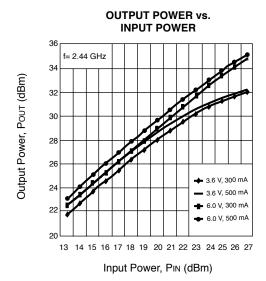


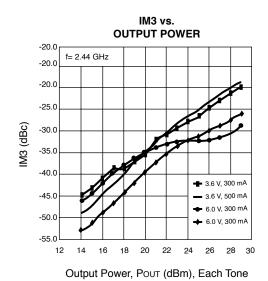


NE5520279A PARTS LIST

1	SD-500881		SCHEMATIC DIAGRAM NE5520279A-EVAL	18
1	TF-100637		TEST CIRCUIT BLK	17
4			2-56 x 3/16 PHILLIPS PAN HEAD	16
2	MA101J	C2,C3	CASE 1 100pF CAP MURATA	15
1	MCR03J200	R1	0603 20 OHM RESISTOR ROHM	14
1	600S2R7CW	C4	0603 2.7pF CAP ATC	13
1	600S2R2BW	C15	0603 2.2pF CAP ATC	12
1	600S1R2BW	C14	0805 1.2pF CAP ATC	11
2	600S5R6CW	C1, C5	0603 5.6pF CAP ATC	10
1	600S3R3CW	C6	0603 3.3pF CAP ATC	9
2	TAJB475K010R	C12, C13	CASE B 4.7 uF CAP AVX	8
2	GRM40X7R104K025BL	C10, C11	0805 .1uF CAP MURATA	7
2	GRM40C0G102J050BD	C8, C9	0805 1000 pF CAP MURATA	6
1	NE5520279A	U1	IC NEC	5
1	703401	P1	GROUND LUG CONCORD	4
1	1250-003	J3, J4	FEEDTHRU MURATA	3
2	2052-5636-02	J1, J2	FLANGE MOUNT JACK RECEPTACLE	2
1	FD-500855B	PCB	S-BAND MODULE FABRICATION DRAWING	1

TYPICAL APPLICATION CIRCUIT PERFORMANCE (TA = 25°C)





RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.

Soldering Method	Soldering Conditions	Condition Symbol	
Infrared Reflow	Peak temperature (package surface temperature) Time at peak temperature Time at temperature of 220°C or higher Preheating time at 120 to 180°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 60 seconds or less : 120±30 seconds : 3 times : 0.2%(Wt.) or below	IR260
VPS	Peak temperature (package surface temperature) Time at temperature of 200°C or higher Preheating time at 120 to 150°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 215°C or below : 25 to 40 seconds : 30 to 60 seconds : 3 times : 0.2%(Wt.) or below	VP215
Wave Soldering	Peak temperature (molten solder temperature) Time at peak temperature Preheating temperature (package surface temperature) Maximum number of flow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 120°C or below : 1 time : 0.2%(Wt.) or below	WS260
Partial Heating	Peak temperature (pin temperature) Soldering time (per pin of device) Maximum chlorine content of rosin flux (% mass)	: 350°C or below : 3 seconds or less : 0.2%(Wt.) or below	HS350-P3

Caution Do not use different soldering methods together (except for partial heating).

Life Support Applications

These NEC products are not intended for use in life support devices, appliances, or systems where the malfunction of these products can reasonably be expected to result in personal injury. The customers of CEL using or selling these products for use in such applications do so at their own risk and agree to fully indemnify CEL for all damages resulting from such improper use or sale.

California Eastern Laboratories, Your source for NEC RF, Microwave, Optoelectronic, and Fiber Optic Semiconductor Devices.
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Facsimile: (408) 988-0279



Subject: Compliance with EU Directives

CEL certifies, to its knowledge, that semiconductor and laser products detailed below are compliant with the requirements of European Union (EU) Directive 2002/95/EC Restriction on Use of Hazardous Substances in electrical and electronic equipment (RoHS) and the requirements of EU Directive 2003/11/EC Restriction on Penta and Octa BDE.

CEL Pb-free products have the same base part number with a suffix added. The suffix –A indicates that the device is Pb-free. The -AZ suffix is used to designate devices containing Pb which are exempted from the requirement of RoHS directive (*). In all cases the devices have Pb-free terminals. All devices with these suffixes meet the requirements of the RoHS directive.

This status is based on CEL's understanding of the EU Directives and knowledge of the materials that go into its products as of the date of disclosure of this information.

Restricted Substance per RoHS	Concentration Limit per RoHS (values are not yet fixed)	Concentration contained in CEL devices		
Lead (Pb)	< 1000 PPM	-A Not Detected	-AZ (*)	
Mercury	< 1000 PPM	Not Detected		
Cadmium	< 100 PPM	Not Detected		
Hexavalent Chromium	< 1000 PPM	Not Detected		
PBB	< 1000 PPM	Not Detected		
PBDE	< 1000 PPM	Not Detected		

If you should have any additional questions regarding our devices and compliance to environmental standards, please do not hesitate to contact your local representative.

Important Information and Disclaimer: Information provided by CEL on its website or in other communications concerting the substance content of its products represents knowledge and belief as of the date that it is provided. CEL bases its knowledge and belief on information provided by third parties and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. CEL has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. CEL and CEL suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall CEL's liability arising out of such information exceed the total purchase price of the CEL part(s) at issue sold by CEL to customer on an annual basis.

See CEL Terms and Conditions for additional clarification of warranties and liability.